

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PTO PATENT AND TRADEMARK OFFICE <div style="border: 1px solid black; border-radius: 50%; padding: 5px; display: inline-block; text-align: center;"> AUG 25 2004 RECEIVED EXAMINER OFFICE 9010 </div> LIST OF REFERENCES CITED BY APPLICANT (Use Several Sheets if Necessary)		DOCKET NO. 2343-185-27	SERIAL NO. 10/825,181
APPLICANT JOHN T. BERRY, ET AL.		FILING DATE APRIL 16, 2004	
GROUP ART UNIT 2857 2863			

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	AA	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						

FOREIGN PATENT DOCUMENTS					
AC	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO	
	AC				
	AD				

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)		
133	AE	Proffen, et al., Interactive Guide to Diffraction", http://www.uni-wuerzburg.de/mineralogie/crystal/teaching/teaching.html (2003). 8 pages
133	AF	Simes, et al., "A Note on the Influence of Residual Stress on Measured Hardness, Research Note", Journal of Strain Analysis, 19(2):135-137 (1984).
133	AG	Tissue B.M., Chemistry Hypermedia Project, http://www.chem.vt.edu/chem-ed/diffraction/neutron.html (2000). 4 pages
	AH	
	AI	
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	AQ	

EXAMINER <i>Berry</i>	DATE CONSIDERED 12/28/04
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*EXAMINER: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.